

Notice of References Cited		Application/Control No. 10/567,790	Applicant(s)/Patent Under Reexamination NAGOH ET AL.	
		Examiner MICHAEL M. BERNSHTEYN	Art Unit 1796	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0263745	12-2005	Momoda et al.	252/586
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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